Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/707,685	LEE ET AL.	
Examiner	Art Unit	
MATTHEW V. NGUYEN	2838	

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Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Interference Search: see search history printout	11/4/05	WN	
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